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APPLICANT: William B. Euler et al. GROUP: 2877
SERIAL NO: 09/762,863 EXAMINER: Lee, Hwa S.
FILED: May 2, 2001
FOR: THIN FILM STRAIN SENSORS BASED ON INTER-FEROMETRIC
OPTICAL MEASUREMENTS

Commissioner of Patents
P.O. Box 1450
Alexandria, VA 22313-1450


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INFORMATION DISCLOSURE STATEMENT

In compliance with 37 C.F.R. §§1.56, 1.97, and 1.98, Applicant submits copies of the documents listed on the attached Form PTO-1449. A check for \$180.00 to cover the Information Disclosure Statement fee is enclosed.

The Commissioner is authorized to charge Deposit Order Account No. 19-0079 for any further fee that is required.

Respectfully submitted,


Richard L. Stevens, Jr.
Registration No. 44,357
Gauthier & Connors, LLP
225 Franklin Street, Suite 3300
Boston, Massachusetts 02110
Telephone: (617) 426-9180
Extension 123

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FORM PTO-1449
(Rev. 5/92)GAUTHIER & CONNORS LLP
225 Franklin Street, Boston, MA 02110
Telephone: (617) 426-9180

ATTORNEY DOCKET NO. 4463

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APPLICANT Euler et al.

GROUP 2877

FILING DATE 05/02/2001

EXAMINER Lee, Hwa S.

**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

JUN 21 2004

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	6,281,976	08/28/2001	Taylor et al.			04/08/1998
	AB	5,094,517	03/10/1992	Franke			08/10/1990
	AC	4,781,056	11/01/1988	Noel et al.			03/05/1986
	AD	4,756,606	07/12/1988	Jewell et al.			06/05/1986
	AE						
	AF						
	AG						
	AH						
	AI						

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AJ						
	AK						
	AL						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER INITIAL		
	AM	
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Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.